

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE . PATENT AND TRADEMARK OFFICE

ATTORNEY DOCKET NO. 1293.1825CIP

Sheet 1 of 1

FIRST NAMED INVENTOR

10/647,134

LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

Young-min CHEONG, et al. FILING DATE GROUP ART UNIT

August 25, 2003

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AH	2000-67444	3/3/00	Japan			Abstr.	
Al	2003-173557	6/20/03	Japan			Abstr.	
AJ	2000-293874	10/20/00	Japan .			Abstr.	
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/William Klimowicz/ (05/08/2006)

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U.S. DEPARTMENT OF COMMERCE

ATTORNEY DOCKET NO.

Sheet 1 of 1

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10/647,134 1293.1825CIP FIRST NAMED INVENTOR

LIST OF REFERENCES CITED BY APPLICANT

Young-min CHEONG, et al.

FILING DATE

August 25, 2003

GROUP ART UNIT 2627

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(Use several sheets if necessary)

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Sheet 1 of 1 APPLICATION NO.

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1293.1825CIP 10/647,134

FIRST NAMED INVENTOR

Young-min CHEONG, et al.

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Sheet 1 of 1 APPLICATION NO. 10/647,134

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Young-min CHEONG, et al.

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